June 2004



RMWM38001

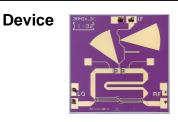
38 GHz Mixer MMIC

General Description

The RMWM38001 is a 38 GHz Mixer designed for use in point to point and point to multi-point radios, and various communications applications. In conjunction with other Fairchild RF Components amplifiers, multipliers and mixers it forms part of a complete 38 GHz transmit/receive chipset. The RMWM38001 is a GaAs MMIC diode mixer utilizing our 0.25µm power PHEMT process. The MMIC can be used as both an Upconverter and a Downconverter and is sufficiently versatile to serve in a variety of mixer applications.

Features

- 4mil substrate
- Conversion loss 5dB (Upconverter)
- Conversion loss 8dB (Downconverter)
- · No DC bias required
- Chip size 1.4mm x 1.4mm



Absolute Ratings

Symbol	Parameter	Ratings	Units
P _{IN}	RF Input Power (from 50Ω source)	+25	dBm
T _C	Operating Baseplate Temperature	-30 to +85	°C
T _{stg}	Storage Temperature Range	-55 to +125	°C

Electrical Characteristics (At 25°C), 50 Ω system, LO = +12 dBm

Parameter	Min	Тур	Max	Units
RF Frequency Range	37		40	GHz
LO Frequency Range		32–35		GHz
IF Frequency Range		4.7–5.3		GHz
LO Drive Power		12	16	dBm
Up Conversion Loss		5		dB
Down Conversion Loss ¹		8	10	dB
Conversion Loss Variation vs Freq.		3		dB

Note:

1: Device 100% RF tested as downconverter only. L0 drive = +12dBm, RF Pin = -10dBm, IF = 5GHz.

Application Information

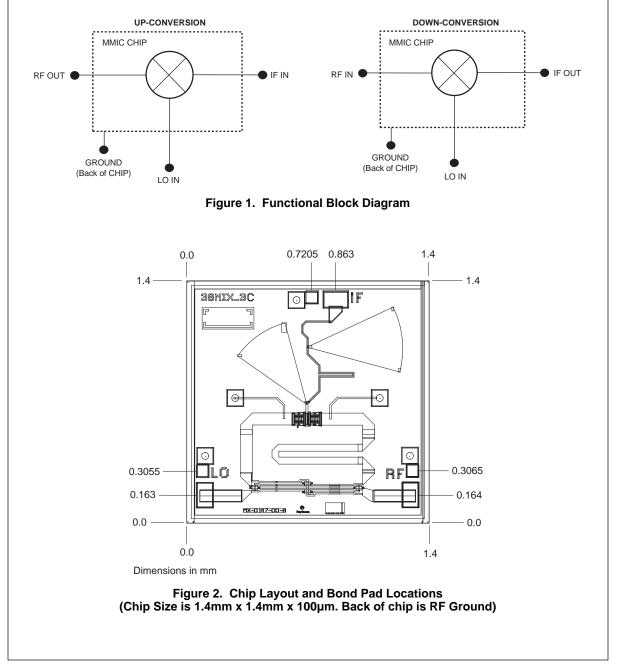
CAUTION: THIS IS AN ESD SENSITIVE DEVICE.

Chip carrier material should be selected to have GaAs compatible thermal coefficient of expansion and high thermal conductivity such as copper molybdenum or copper tungsten. The chip carrier should be machined, finished flat, plated with gold over nickel and should be capable of withstanding 325°C for 15 minutes.

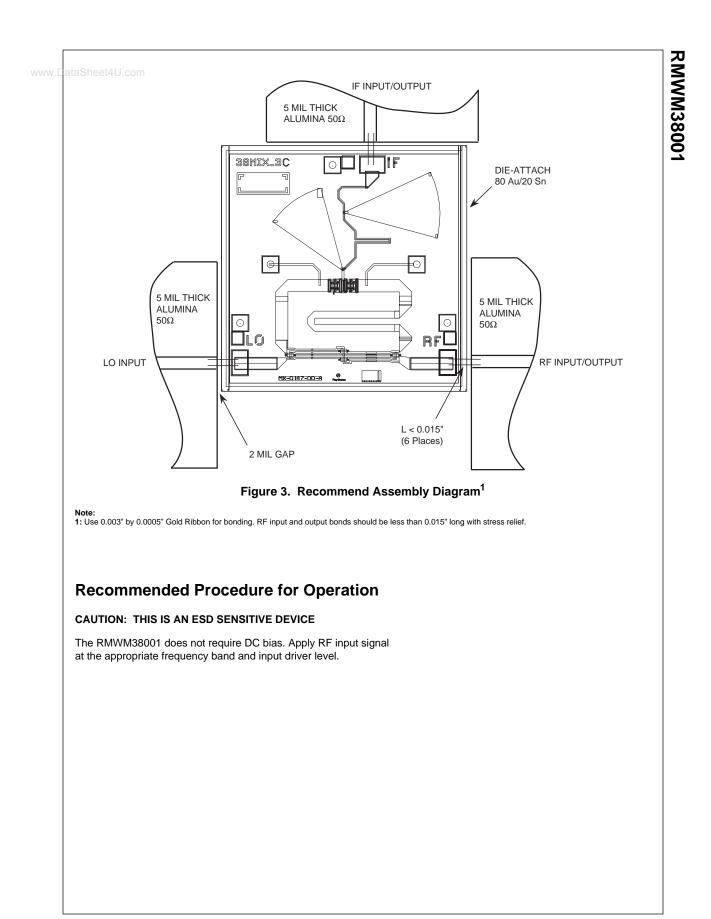
Die attachment should utilize Gold/Tin (80/20) eutectic alloy solder and should avoid hydrogen environment for PHEMT devices. Note that the backside of the chip is gold plated and is used as RF ground.

These GaAs devices should be handled with care and stored in dry nitrogen environment to prevent contamination of bonding surfaces. These are ESD sensitive devices and should be handled with appropriate precaution including the use of wrist grounding straps. All die attach and wire/ribbon bond equipment must be well grounded to prevent static discharges through the device.

Recommended wire bonding uses 3mils wide and 0.5mil thick gold ribbon with lengths as short as practical allowing for appropriate stress relief. The RF input and output bonds should be typically 0.012" long corresponding to a typical 2mil gap between the chip and the substrate material.

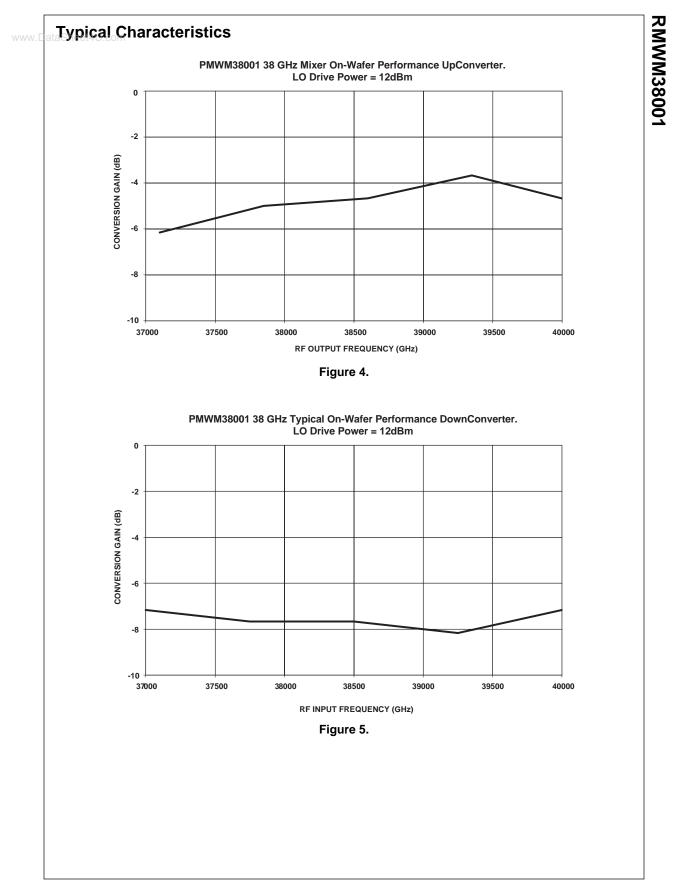


©2004 Fairchild Semiconductor Corporation



©2004 Fairchild Semiconductor Corporation

RMWM38001 Rev. D



©2004 Fairchild Semiconductor Corporation

The following are rendered to be a				iconductor owns or is author	rized to use and is
ACEx™	FAST®		ISOPLANAR™	Power247™	SuperFET™
ActiveArray™	FASTr™		LittleFET™	PowerSaver™	SuperSOT™-:
Bottomless™	FPS™		MICROCOUPLER™		SuperSOT [™] -(
CoolFET™	FRFET™		MicroFET™	QFET [®]	SuperSOT [™] -8
CROSSVOLT™		isolator™	MicroPak™	QS™	SyncFET™
DOME™	GTO™ GTO™	13012101	MICROWIRE™	QT Optoelectronics™	TinyLogic®
EcoSPARK™	HiSeC™		MSX™	Quiet Series [™]	TINYOPTO™
E ² CMOS [™]	PC™		MSXPro™	RapidConfigure™	TruTranslation
EnSigna™	i-Lo™		OCX™	RapidConnect™	UHC™
FACT [™] ImpliedDisconnect [™] FACT Quiet Series [™]			μSerDes™	UltraFET®	
		OPTOLOGIC [®]	SILENT SWITCHER [®]	VCX™	
				SMART START™	
Across the boar	Across the board. Around the world.™		PACMAN™	SPM™	
The Power Franchise [®] Programmable Active Droop™		POP™	Stealth™		
FAIRCHILD SEMICO PRODUCTS HEREIN ARISING OUT OF TH	N TO IMPROVE	RELIABILITY NOR USE OF	, FUNCTION OR DESIGN. F	ES WITHOUT FURTHER NOT FAIRCHILD DOES NOT ASSU JIT DESCRIBED HEREIN; NEI OF OTHERS.	ME ANY LIABILITY
FAIRCHILD SEMICO PRODUCTS HEREIN ARISING OUT OF TH CONVEY ANY LICEN LIFE SUPPORT PO FAIRCHILD'S PROI DEVICES OR SYSTE As used herein: 1. Life support devi systems which, (a) a the body, or (b) sup failure to perform w with instructions for reasonably expecte user. PRODUCT STATUS	N TO IMPROVE IE APPLICATION NSE UNDER ITS LICY DUCTS ARE NO EMS WITHOUT ices or systems are intended for opport or sustain when properly u use provided in d to result in si DEFINITIONS	RELIABILITY NOR USE OF PATENT RIC OT AUTHOF THE EXPRES are devices r surgical imp life, or (c) v used in acco n the labelin	FUNCTION OR DESIGN. F ANY PRODUCT OR CIRCU GHTS, NOR THE RIGHTS C RIZED FOR USE AS CRIT SWRITTEN APPROVALO s or 2. A critical plant into support de whose be reasonar rdance support de g, can be effectiven	AIRCHILD DOES NOT ASSU JIT DESCRIBED HEREIN; NEI FOTHERS. ICAL COMPONENTS IN LIF F FAIRCHILD SEMICONDUCT al component is any component vice or system whose failure ably expected to cause the avice or system, or to affect	THER DOES IT THER DOES IT FE SUPPORT FOR CORPORATIC ent of a life to perform can failure of the life
FAIRCHILD SEMICC PRODUCTS HEREIN ARISING OUT OF TH CONVEY ANY LICEN LIFE SUPPORT PO FAIRCHILD'S PROI DEVICES OR SYSTE As used herein: 1. Life support devi systems which, (a) a the body, or (b) sup failure to perform w with instructions for reasonably expecte user. PRODUCT STATUS Definition of Term	N TO IMPROVE IE APPLICATION NSE UNDER ITS UDCTS ARE NO EMS WITHOUT ices or systems are intended for oport or sustain when properly u use provided in d to result in si DEFINITIONS ns	RELIABILITY NOR USE OF PATENT RIC OT AUTHOF THE EXPRES are devices r surgical im life, or (c) v ised in acco n the labelin gnificant inju	FUNCTION OR DESIGN. F ANY PRODUCT OR CIRCL BHTS, NOR THE RIGHTS C RIZED FOR USE AS CRIT SS WRITTEN APPROVAL O s or 2. A critica plant into support de whose be reason rdance support de g, can be effectiven iry to the	AIRCHILD DOES NOT ASSU JIT DESCRIBED HEREIN; NEI OF OTHERS. ICAL COMPONENTS IN LIF F FAIRCHILD SEMICONDUCT al component is any compon evice or system whose failure ably expected to cause the evice or system, or to affect ess.	THER DOES IT THER DOES IT FE SUPPORT FOR CORPORATIC ent of a life to perform can failure of the life
FAIRCHILD SEMICO PRODUCTS HEREIN ARISING OUT OF TH CONVEY ANY LICEN LIFE SUPPORT PO FAIRCHILD'S PROI DEVICES OR SYSTE As used herein: 1. Life support devi systems which, (a) a the body, or (b) sup failure to perform w with instructions for reasonably expecte user. PRODUCT STATUS	N TO IMPROVE IE APPLICATION NSE UNDER ITS UNDER ITS UNDE	RELIABILITY NOR USE OF PATENT RIC OT AUTHOF THE EXPRES are devices r surgical imp life, or (c) v used in acco n the labelin	FUNCTION OR DESIGN. F ANY PRODUCT OR CIRCL GHTS, NOR THE RIGHTS C RIZED FOR USE AS CRIT SS WRITTEN APPROVALO s or 2. A critica plant into support de whose be reason rdance support de g, can be effectiven iry to the Status	AIRCHILD DOES NOT ASSU JIT DESCRIBED HEREIN; NEI FOTHERS. ICAL COMPONENTS IN LIF F FAIRCHILD SEMICONDUCT al component is any component vice or system whose failure ably expected to cause the avice or system, or to affect	THER DOES IT THER DOES IT THER DOES IT FE SUPPORT FOR CORPORATIC ent of a life to perform can failure of the life

	In Design	product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.
		Rev. I11